

Description

The HXY50N03DF uses advanced trench technology

to provide excellent $R_{\text{DS}(\text{ON})},$ low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 30V I_D =50 A

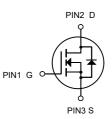
 $R_{DS(ON)} < 10m\Omega @ V_{GS}=10V$

Application

Battery protection

Load switch Uninterruptible power supply





N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HXY50N03DF	DFN3X3-8L	50N03 XXX YYYY	5000

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	50	А
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	30	А
ID@TA=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	11	А
ID@TA=70°C	Continuous Drain Current, V _{GS} @ 10V ¹	9	А
Ідм	Pulsed Drain Current ²	112	А
EAS	Single Pulse Avalanche Energy ³	24.2	mJ
las	Avalanche Current	22	А
P _D @T _C =25°C	Total Power Dissipation ⁴	37.5	W
P _D @T _A =25°C	Total Power Dissipation ⁴	2.42	W
Тѕтс	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C
R _{0JA}	Thermal Resistance Junction-Ambient ¹	62	°C/W
Rejc	Thermal Resistance Junction-Case ¹	4	°C/W



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
$\triangle BV_{DSS} / \triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I⊳=1mA		0.0193		V/°C
		V _{GS} =10V , I _D =30A		7.5	10	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =15A		11	18	mΩ
VGS(th)	Gate Threshold Voltage		1.2		2.5	V
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =250uA		-3.97		mV/°C
		V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	•
loss	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
lgss	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		34		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.8		Ω
Qg	Total Gate Charge (4.5V)			9.8		
Qgs	Gate-Source Charge			4.2		nC
Q_{gd}	Gate-Drain Charge			3.6		
Td(on)	Turn-On Delay Time			4		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V ,		8		
Td(off)	Turn-Off Delay Time	R _G =3.3		31		ns
Tf	Fall Time	I _D =15A		4		
Ciss	Input Capacitance			940		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		131		pF
Crss	Reverse Transfer Capacitance			109		
Is	Continuous Source Current ^{1,5}				43	А
lsм	Pulsed Source Current ^{2,5}	−V _G =V _D =0V , Force Current			112	А
Vsd	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time			8.5		nS
Qrr	Reverse Recovery Charge	IF=30A , dI/dt=100A/µs , TJ=25°C		2.2		nC
				1		

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Note :

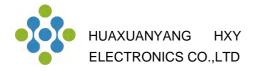
1 .The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\leq 300 us$, duty cycle $\leq 2\%$

3 .The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=22A

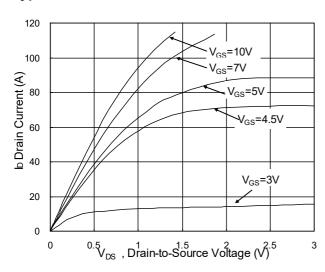
4.The power dissipation is limited by 175 $^\circ\text{C}$ junction temperature

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



HXY50N03DF N-Channel Enhancement Mode MOSFET

Typical Characteristics





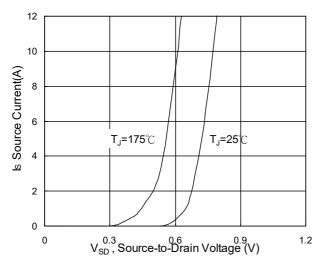


Fig.3 Forward Characteristics of Reverse

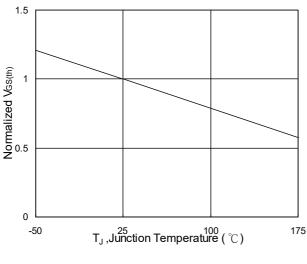


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

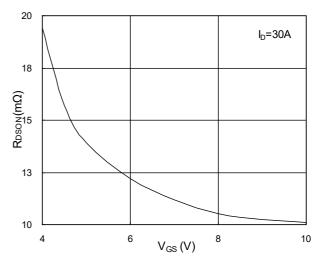


Fig.2 On-Resistance vs. G-S Voltage

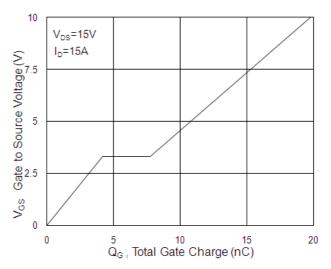


Fig.4 Gate-Charge Characteristics

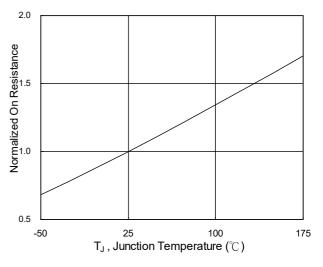
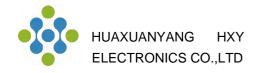


Fig.6 Normalized R_{DSON} vs. T_J



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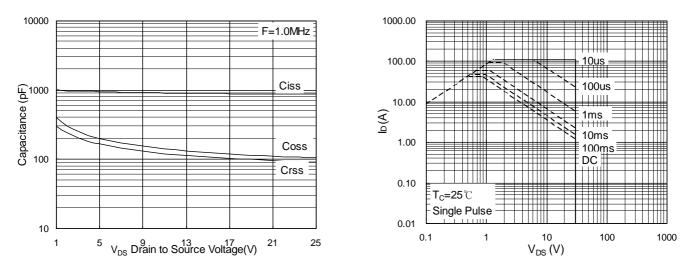
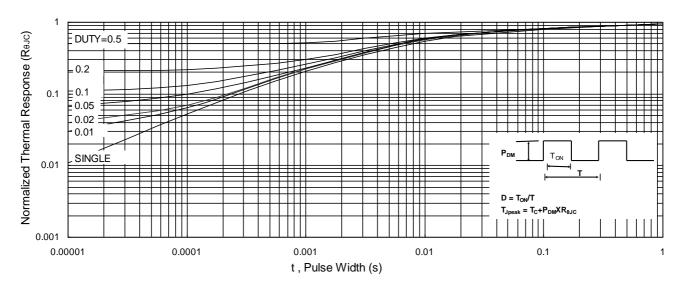


Fig.7 Capacitance

Fig.8 Safe Operating Area





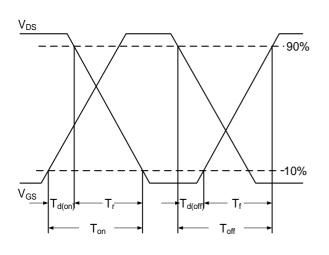


Fig.10 Switching Time Waveform

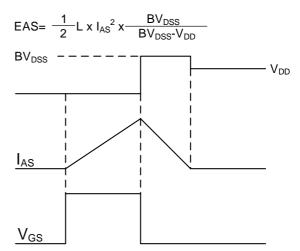
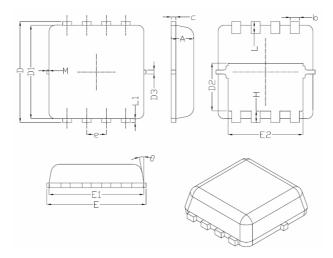


Fig.11 Unclamped Inductive Switching Waveform



DFN3X3-8L Package Information



Symphol	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
М	*	*	0.15	
θ		10 [°]	12 [°]	



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